

Notice of References Cited	Application/Control No. 10/697,108	Applicant(s)/Patent Under Reexamination BEISEL ET AL.	
	Examiner Siu M. Lee	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,205,562 B1	03-2001	Fukushima et al.	714/43
*	B	US-2002/0167694 A1	11-2002	Feinberg et al.	359/110
*	C	US-6,285,475 B1	09-2001	Fee, John Arthur	398/10
*	D	US-6,597,826 B1	07-2003	Ramaswami et al.	385/17
*	E	US-5,790,520	08-1998	Iwamoto et al.	370/223
*	F	US-5,187,706	02-1993	Frankel et al.	370/217
*	G	US-6,928,428 B2	08-2005	De Vries, Jean Pierre	707/3
*	H	US-7,180,867	02-2007	Hoch et al.	370/244
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.